## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | EIJI ET AL. | Examiner | Art Unit | Sunray Chang | 2121 | Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,680,812 B1	01-2004	lwashiro, Masafumi	360/78.06
	В	US-2003/0139826 A1	07-2003	Yasui et al.	700/31
	С	US-2003/0009240 A1	01-2003	Yasui et al.	700/40
	D	US-2003/0028264 A1	02-2003	Yasui et al.	700/29
	E	US-5,687,077	11-1997	Gough, Jr., William Albert Gordon	700/29
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	a						
	R						
	s						
	Т						

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.